

YPN 438S——40V 10A N&P-Channel Power MOSFET (2 IN 1)

General Features

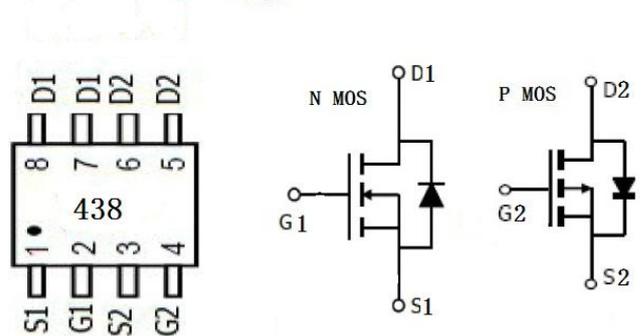
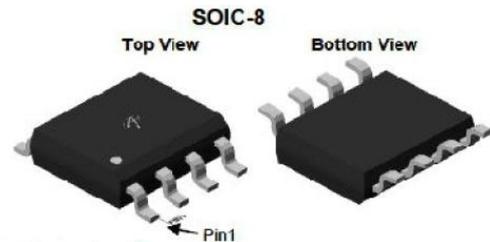
- Proprietary New Trench Technology
- Ultra-low Miller Charge
- N MOS RDS(ON),typ.=18mΩ@V_{GS}=10V
- P MOS RDS(ON),typ.=30mΩ@V_{GS}=10V
- Low Gate Charge Minimize Switching Loss
- Fast Recovery Body Diode

Applications

- High efficiency DC/DC Converters
- Synchronous Rectification
- Motor Drive

Ordering Information

Part Number	Package	Marking
YPN 438S	SOP-8	438



Absolute Maximum Ratings

Absolute Maximum Ratings		T _A =25°C unless otherwise noted			
		Symbol	Maximum		Units
Parameter		N MOS	P MOS		
Drain-Source Voltage	V _{DS}	+40	-40	V	
Gate-Source Voltage	V _{GS}	±20 V	±20 V	V	
Continuous Drain Current	I _D	T _A =25°C	12.2	-10	A
		T _A =70°C	8.5	-8	
Pulsed Drain Current	I _{DM}	35	-30		
Maximum Power Dissipation		2.5	2.8	W	
Operating Junction and Storage Temperature Range	T _J , T _{STG}	-55 to 150		°C	

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device

Thermal Characteristics

Symbol	Parameter	Value	Unit
R _{θJC}	Thermal Resistance, Junction-to-Case	4.0	°C/W
R _{θJA}	Thermal Resistance, Junction-to-Ambient	42	

Electrical Characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Units
Off Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	$I_D = \pm 250mA, V_{GS} = 0V$	± 40			V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = \pm 40V, V_{GS} = 0V$			1	μA
I_{GSS}	Gate-Body leakage current	$V_{DS} = 0V, V_{GS} = \pm 20V$			± 100	nA
On Characteristics (Note 3)						
$V_{GS(th)}$	Gate Threshold Voltage	NMOS: $V_{DS} = V_{GS}, I_D = 250mA$	1	1.5	2.5	V
		PMOS: $V_{DS} = V_{GS}, I_D = -250mA$	-1.1	-1.7	-2.5	
$R_{DS(ON)}$	Static Drain-Source On-Resistance	NMOS: $V_{GS} = 10V, I_D = 10A$		15	18	$m\Omega$
		NMOS: $V_{GS} = 4.5V, I_D = 8A$		22	35	
		PMOS: $V_{GS} = -10V, I_D = -7.2A$		27	32	$m\Omega$
		PMOS: $V_{GS} = -4.5V, I_D = -5.6A$		32	38	
g_{FS}	Forward Transconductance	NMOS: $V_{DS} = 5V, I_D = 8A$	13			S
		PMOS: $V_{DS} = -5V, I_D = -5A$	20			
Drain-Source Diode Characteristics						
V_{SD}	Diode Forward Voltage _(Note 3)	NMOS: $V_{GS} = 0V, I_S = 8A$			1.2	V
		PMOS: $V_{GS} = 0V, I_S = -6A$				
I_S	Maximum Body-Diode Continuous Current _(Note 2)	NMOS			10	A
		PMOS			-6.2	
t_{rr}	Body Diode Reverse Recovery Time	NMOS: $T_J = 25^\circ C, I_F = 10A, di/dt = 100A/\mu s$ _(Note3)		35		ns
		PMOS: $T_J = 25^\circ C, I_F = -7A, di/dt = 100A/\mu s$ _(Note3)		60		
Dynamic Characteristics (Note4)						
C_{iss}	Input Capacitance	NMOS		500		pf
C_{oss}	Output Capacitance	$V_{DS} = 20V, V_{GS} = 0V, F = 1.0MHz$		60		
C_{rss}	Reverse Transfer Capacitance			25		
C_{iss}	Input Capacitance	PMOS		1750		
C_{oss}	Output Capacitance	$V_{DS} = -20V, V_{GS} = 0V, F = 1.0MHz$		215		
C_{rss}	Reverse Transfer Capacitance			180		

Symbol	Parameter	Conditions	Min	Typ	Max	Units
Switching Characteristics (Note 4)						
Q _g	Total Gate Charge	NMOS : V _{GS} =10V, V _{DS} =20V, I _D =8A		14		nC
Q _{gs}	Gate Source Charge			2.9		
Q _{gd}	Gate Drain Charge			5.2		
Q _g	Total Gate Charge	PMOS : V _{GS} =-10V, V _{DS} =-20V, I _D =-5A		24		nC
Q _{gs}	Gate Source Charge			3.5		
Q _{gd}	Gate Drain Charge			6		
t _{d(on)}	Turn-On Delay time	NMOS: V _{DD} =20V, I _D =2A, R _L =6.7Ω V _{GS} =10V, R _G =3Ω		5		ns
t _r	Turn-On Rise Time			2.6		
t _{d(off)}	Turn-Off Delay Time			16.1		
t _f	Turn-Off Fall Time			2.3		
t _{d(on)}	Turn-On Delay Time	PMOS: V _{DD} =-20V, I _D =-2A, R _L =2Ω, V _{GS} =-10V, R _{GEN} =3Ω		9		ns
t _r	Turn-On Rise Time			8		
t _{d(off)}	Turn-Off Delay Time			28		
t _f	Turn-Off Fall Time			10		

Notes:

1. Repetitive Rating: Pulse width limited by maximum junction temperature.
2. Surface Mounted on FR4 Board, t ≤ 10 sec.
3. Pulse Test: Pulse Width ≤ 300μs, Duty Cycle ≤ 2%.
4. Guaranteed by design, not subject to production

Typical Electrical and Thermal Characteristics (Curves):P MOS

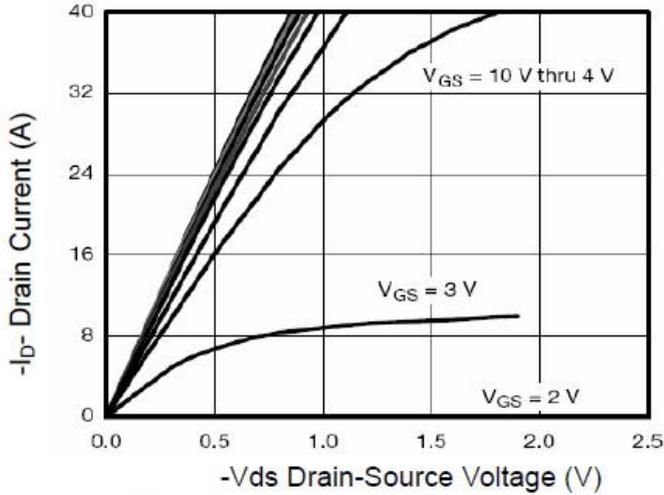


Figure 1 Output Characteristics

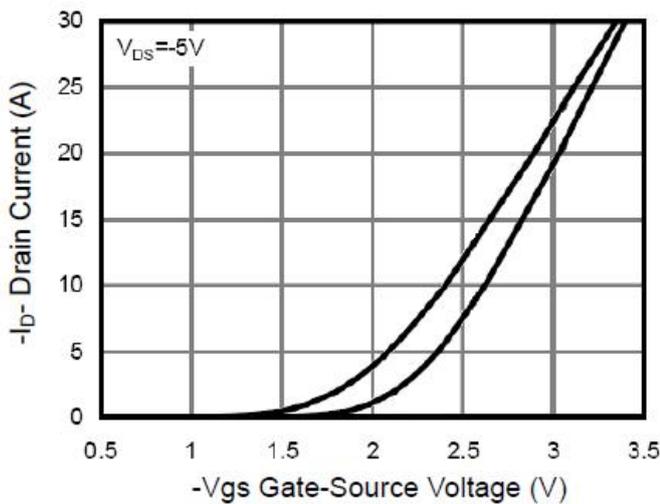


Figure 2 Transfer Characteristics

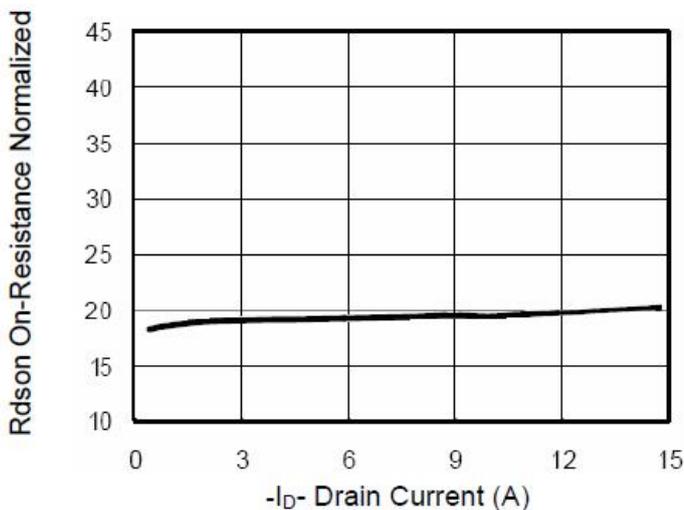


Figure 3 Rdson- Drain Current

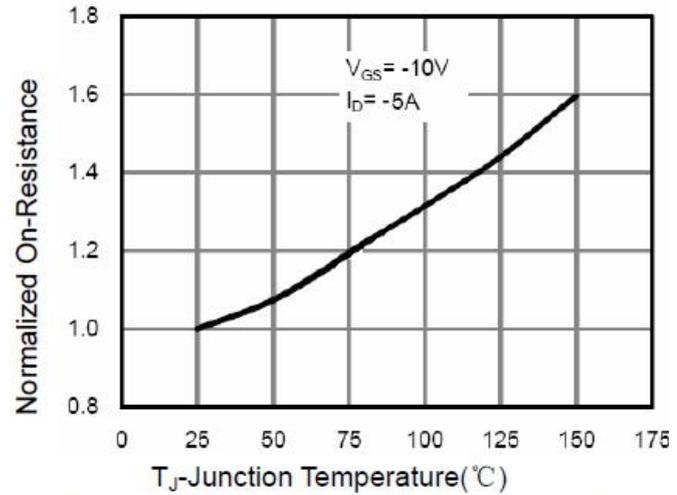


Figure 4 Rdson-Junction Temperature

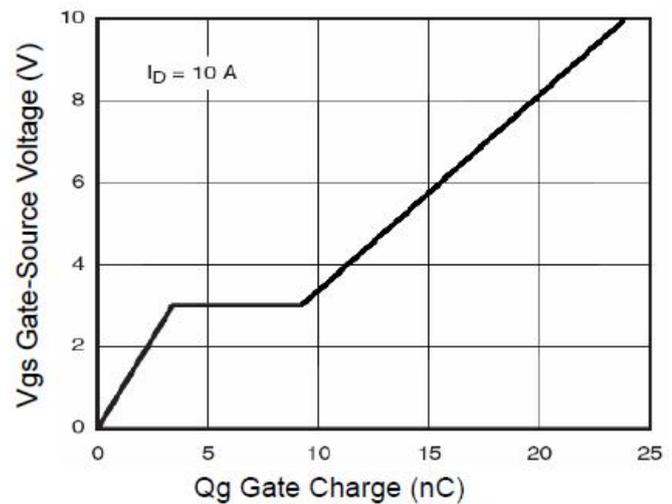


Figure 5 Gate Charge

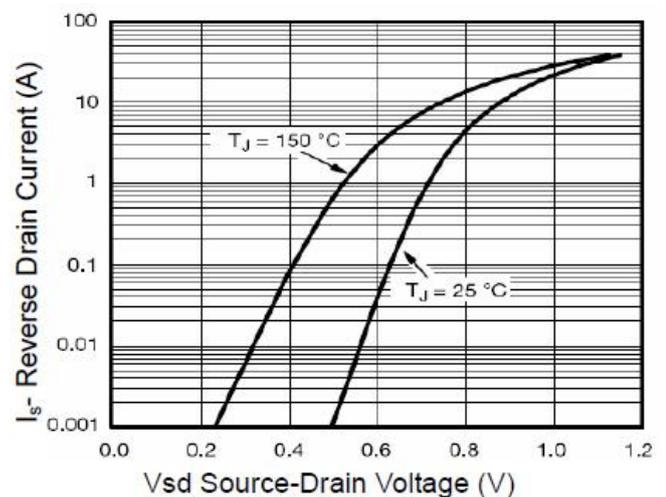


Figure 6 Source- Drain Diode Forward

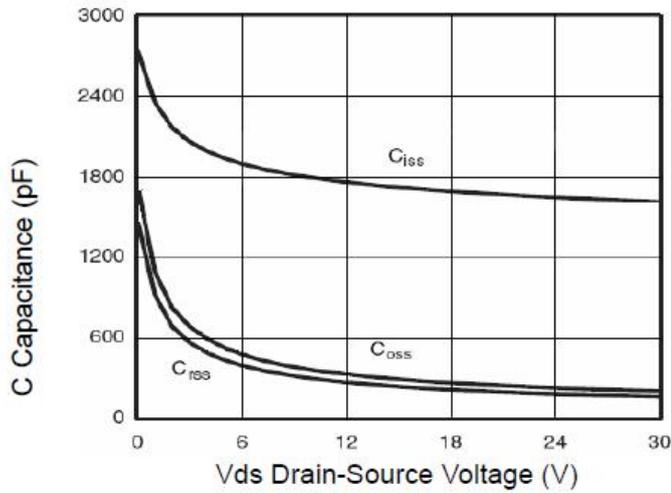


Figure 7 Capacitance vs Vds

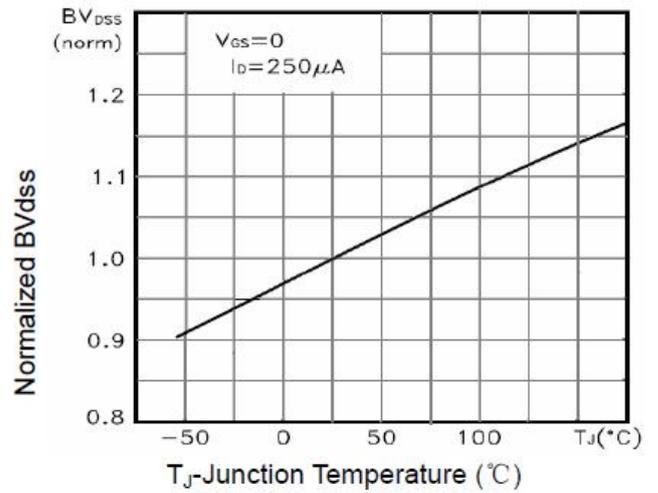


Figure 9 BV_{DSS} vs Junction Temperature

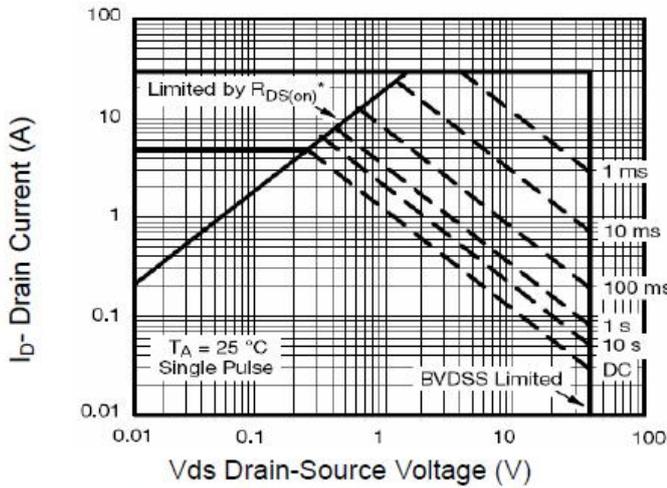


Figure 8 Safe Operation Area

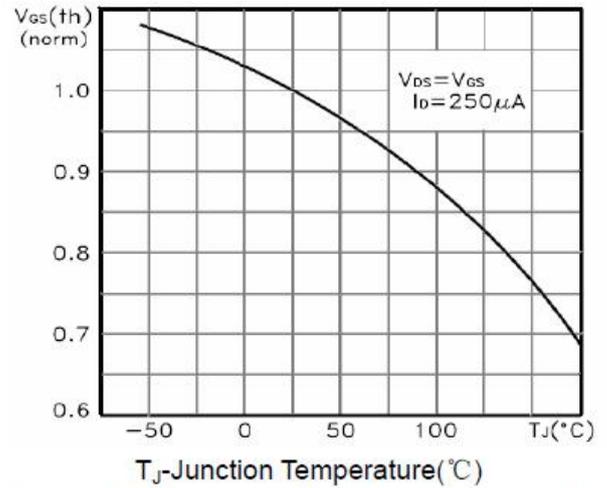


Figure 10 $V_{GS(th)}$ vs Junction Temperature

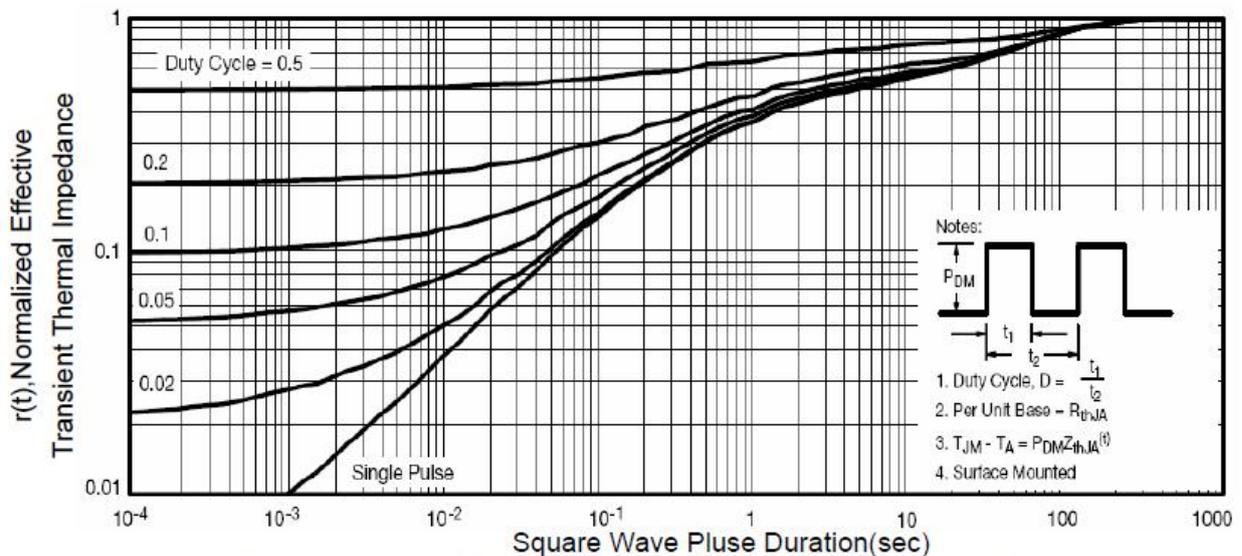


Figure 11 Normalized Maximum Transient Thermal Impedance

Typical Electrical and Thermal Characteristics (Curves):N MOS

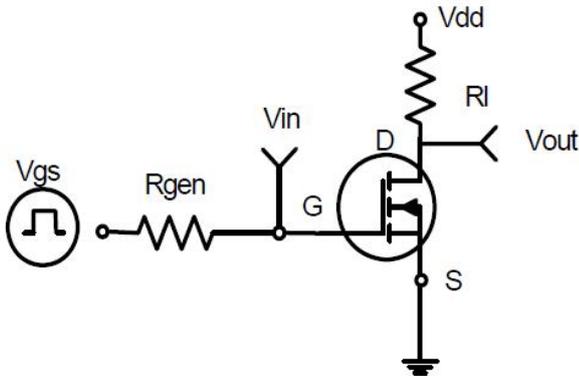


Figure 1: Switching Test Circuit

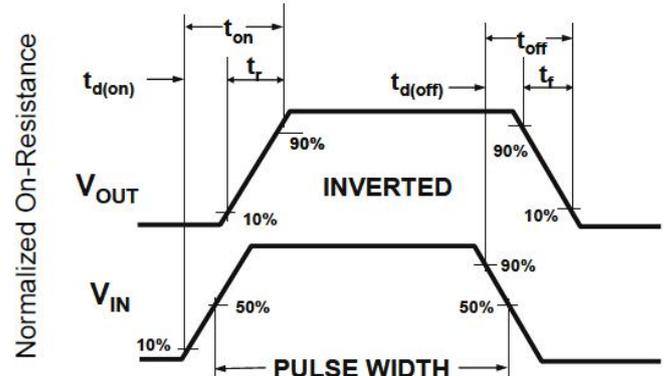


Figure 2: Switching Waveforms

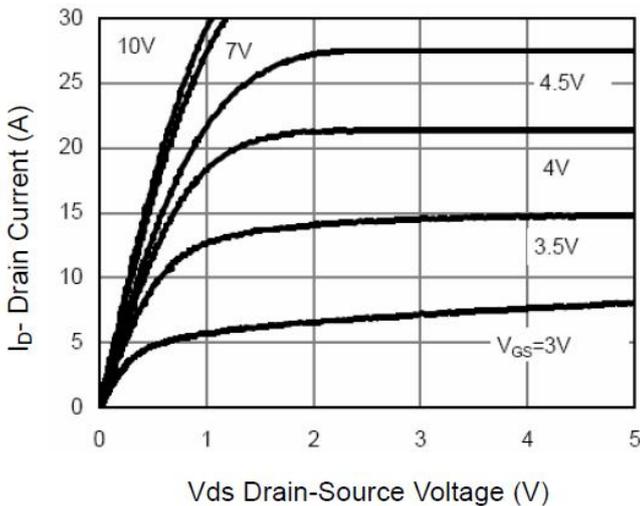


Figure 3 Output Characteristics

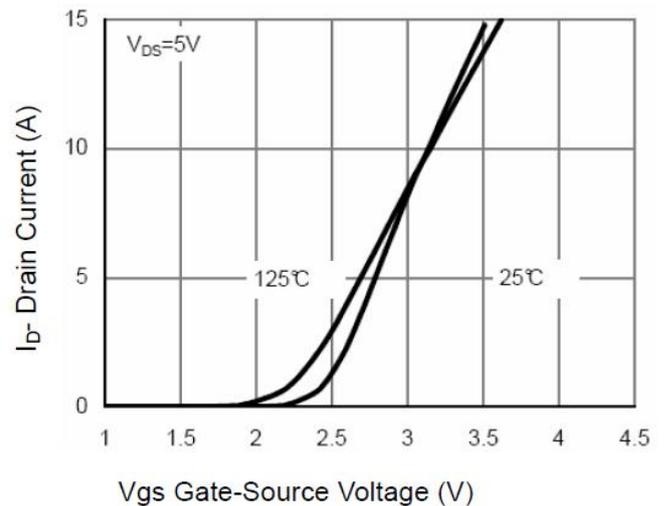


Figure 4 Transfer Characteristics

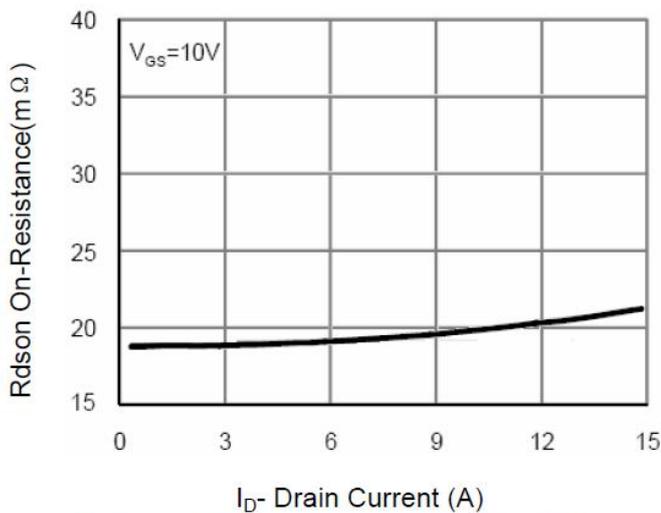


Figure 5 Drain-Source On-Resistance

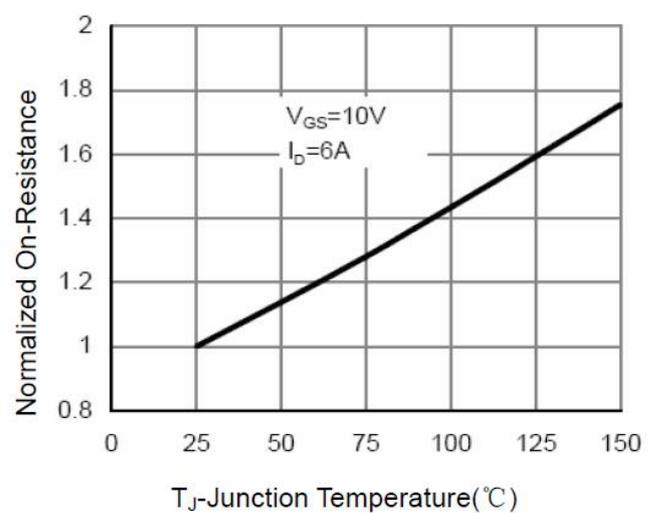


Figure 6 Drain-Source On-Resistance

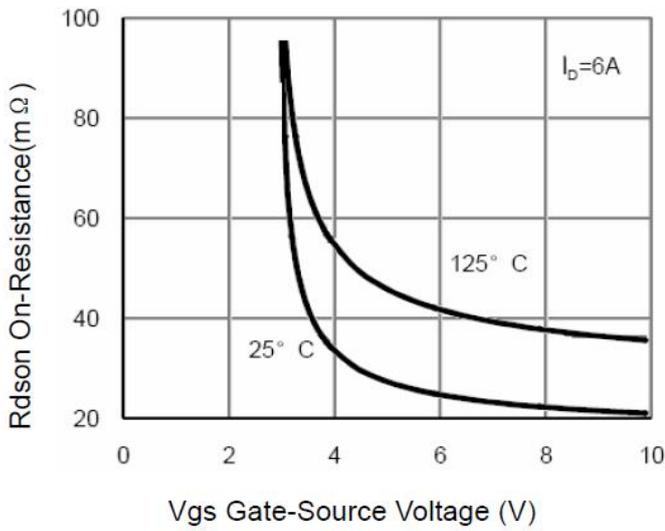


Figure 7 Rdson vs Vgs

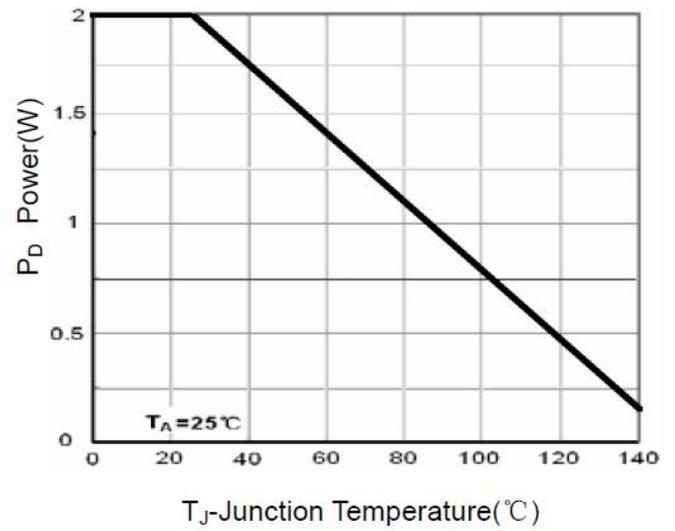


Figure 8 Power Dissipation

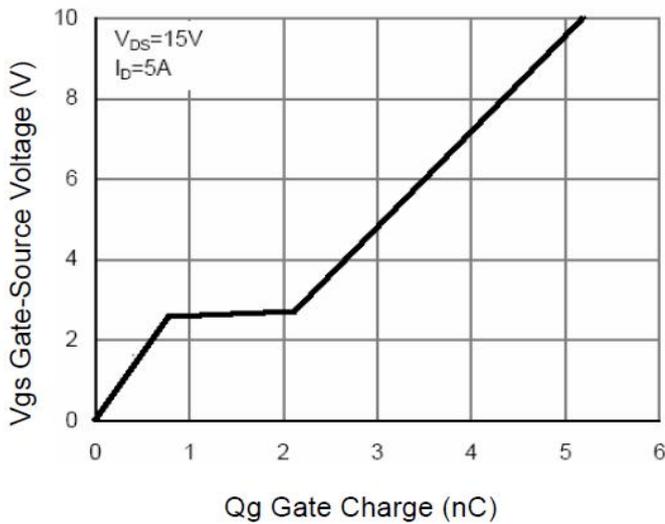


Figure 9 Gate Charge

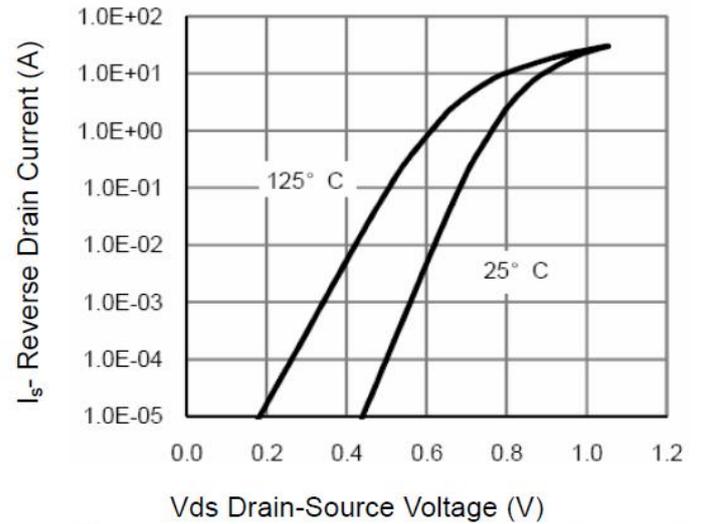


Figure 10 Source- Drain Diode Forward

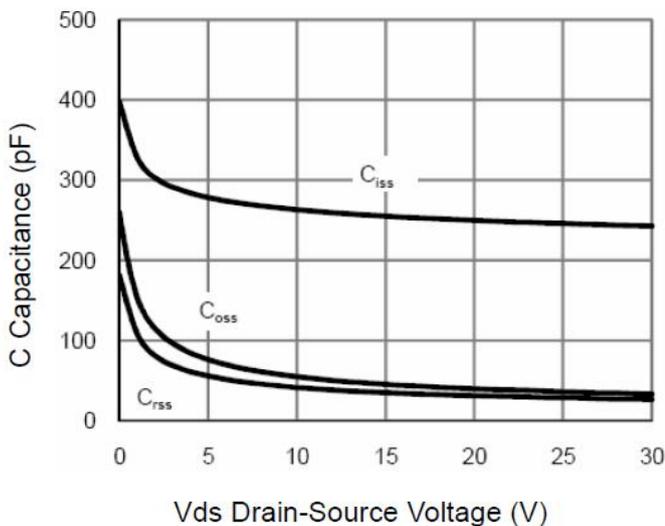


Figure 11 Capacitance vs Vds

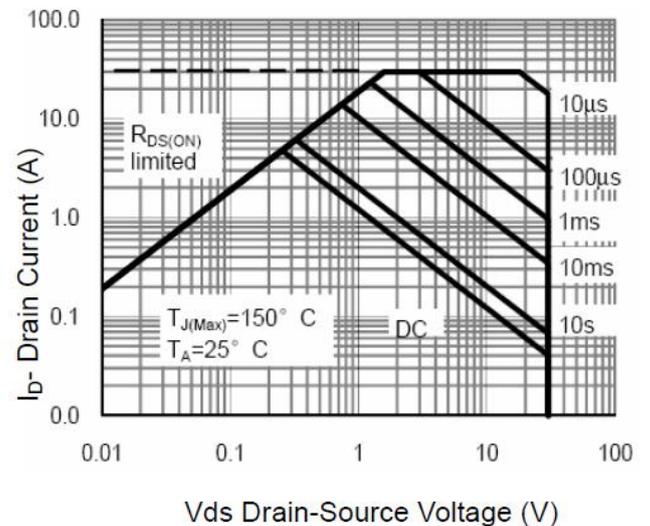


Figure 12 Safe Operation Area

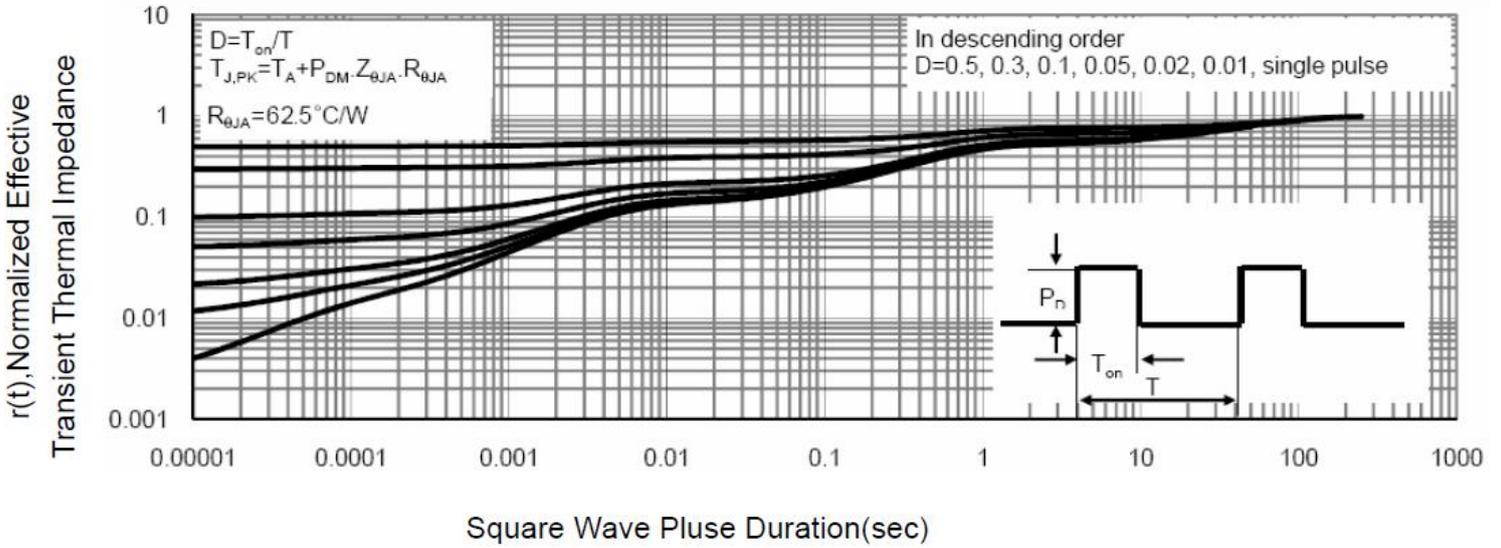


Figure 13 Normalized Maximum Transient Thermal Impedance

Order information:

Order information							
	Y	2	N/	6	55	S	()
公司商标代号 Company symbol							
1: NIL ,2:2 MOS							
P: PMOS, N:N MOS							
BVDSS: 6—60V;10—100V;20—200V; 35—350V; 40—400V							
RDS(on) : 55—55m Ω ;38—38m Ω ; 16—16m Ω							
D:DIP;S:SOP							
Special code							

